

Notice of References Cited

Application/Control No.

10/577,857

Applicant(s)/Patent Under
Reexamination
KSONTINI ET AL.

Examiner

MICHAEL R. VAUGHAN

Art Unit

2131

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,809,413 A	09-1998	Meche et al.	455/411
*	B	US-2002/0012433 A1	01-2002	Haverinen et al.	380/247
*	C	US-2002/0062451 A1	05-2002	Scheidt et al.	713/201
*	D	US-2002/0169983 A1	11-2002	Rygaard, Christoper A.	713/201
*	E	US-2003/0114144 A1	06-2003	Minemura, Atsushi	455/410
*	F	US-6,609,199 B1	08-2003	DeTreville, John	713/172
*	G	US-2004/0019790 A1	01-2004	Aono et al.	713/172
*	H	US-2004/0172542 A1	09-2004	Minemura, Atsushi	713/176
*	I	US-2004/0250074 A1	12-2004	Kilian-Kehr, Roger	713/172
*	J	US-6,925,560 B1	08-2005	Basquin, Bruno	713/169
*	K	US-7,065,783 B2	06-2006	Rygaard, Christopher A.	726/4
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2001312402 A	11-2001	Japan	YAMAZAKI et al.	G06F 09/06
	O	JP 20021521996 A	05-2002	Japan	ICHISE N	G06F 09/06
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.